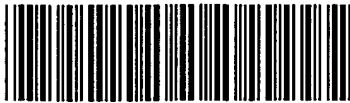


Search Notes



Application/Control No.

10/533,358

Examiner

Charles Chow

Applicant(s)/Patent under
Reexamination

MIYAGI ET AL.

Art Unit

2618

SEARCHED

Class	Subclass	Date	Examiner
455	226.1*	10/20/2006	C.C.
	67.11*, 143, 115.2*, 173.1, 1, 75,		
	56.1, 152.1, 295, 456.5, 42,		
	550.1, 575.1, 42.2, 456.6, 423*,		
	67.13, 115.1, 115.2-115.4, 134, 135,		
	226.2-226.4, 258, 259, 260, 180, 3,		
	318, 334, 272.1,		
342	174, 464, 173, 374, 368,		
	360, 372, 169,		
375	344, 343, 316, 219, 228,		
	345, 224,		
Test, measure	702, 84, 85, 107, 108,		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
See East search in folder or in eDAN.	10/20/2006	C.C.